

Attorney Docket No.: SEN-019

Title of Invention: OVERLAY ALIGNMENT METROLOGY

USING DIFFRACTION GRATINGS

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This application claims priority from three U.S. provisional applications namely: application no. 60/268,485 filed February 12, 2001; application no. 60/295,111 filed June 1, 2001; and application no. 60/322,219 filed September 14, 2001.

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